CMOS Digital Integrated Circuits Silicon Monolithic

# 74VHCT573AFT

#### 1. Functional Description

Octal D-Type Latch with 3-State Outputs

#### 2. General

The 74VHCT573A is an advanced high speed CMOS OCTAL LATCH with 3-STATE OUTPUT fabricated with silicon gate  $C^2MOS$  technology.

It achieves the high speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation.

This 8-bit D-type latch is controlled by a latch enable input (LE) and an output enable input  $(\overline{OE})$ . When the  $\overline{OE}$  input is high, the eight outputs are in a high impedance state.

The input voltage are compatible with TTL output voltage.

This device may be used as a level converter for interfacing  $3.3\mathrm{V}$  to  $5\mathrm{~V}$  system.

Input protection and output circuit ensure that 0 to 5.5 V can be applied to the input and output (Note) pins without regard to the supply voltage. These structure prevents device destruction due to mismatched supply and input/output voltages such as battery back up, hot board insertion, etc.

Note: Output in off-state

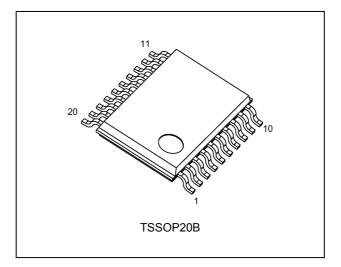
#### 3. Features

- (1) AEC-Q100 (Rev. H) (Note 1)
- (2) Wide operating temperature range:  $T_{opr}$  = -40 to 125 °C
- (3) High speed: Propagation delay time = 7.7 ns (typ.) at  $V_{CC}$  = 5.0 V
- (4) Low power dissipation:  $I_{CC} = 4.0 \ \mu A \ (max)$  at  $T_a = 25^{\circ}C$
- (5) Compatible with TTL inputs:  $V_{IL} = 0.8 V (max)$

#### $V_{IH} = 2.0 V (min)$

- (6) Power down protection is provided on all inputs and outputs.
- (7) Balanced propagation delays:  $t_{PLH} \approx t_{PHL}$
- (8) Low noise:  $V_{OLP} = 1.5 V (max)$
- (9) Pin and function compatible with the 74 series (74ACT/HCT/AHCT etc.) 573 type.
- Note 1: This device is compliant with the reliability requirements of AEC-Q100. For details, contact your Toshiba sales representative.

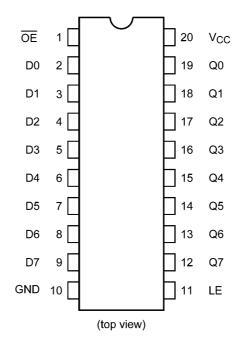
#### 4. Packaging



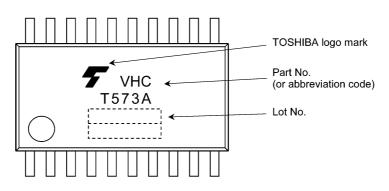
Start of commercial production 2013-04 2016-08-04 Rev.3.0

# 5. Pin Assignment

**TOSHIBA** 



## 6. Marking



7. IEC Logic Symbol

2

# TOSHIBA

#### 8. Truth Table

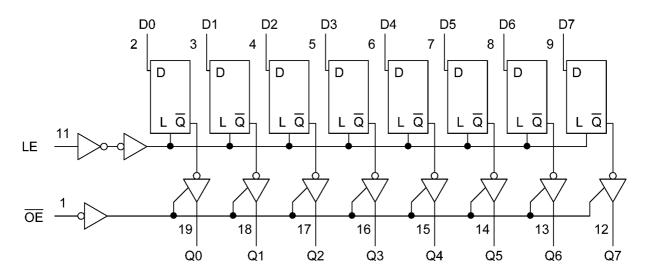
	INPUT LE	INPUT D	OUTPUT
Н	Х	Х	Z
L	L	Х	Qn
L	Н	L	L
L	Н	Н	Н

X: Don't care

Z: High impedance

Qn: Q outputs are latched at the time when the LE input is taken to a low logic level.

#### 9. System Diagram



#### 10. Absolute Maximum Ratings (Note)

Characteristics	Symbol	Note	Rating	Unit
Supply voltage	V <sub>CC</sub>		-0.5 to 7.0	V
Input voltage	V <sub>IN</sub>		-0.5 to 7.0	V
Output voltage	V <sub>OUT</sub>	(Note 1)	-0.5 to 7.0	V
		(Note 2)	-0.5 to V <sub>CC</sub> + 0.5	
Input diode current	I <sub>IK</sub>		-20	mA
Output diode current	I <sub>OK</sub>	(Note 3)	±20	mA
Output current	I <sub>OUT</sub>		±25	mA
V <sub>CC</sub> /ground current	I <sub>CC</sub>		±75	mA
Power dissipation	PD	(Note 4)	180	mW
Storage temperature	T <sub>stg</sub>		-65 to 150	°C

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: Output in off-state

Note 2: High or low state. I<sub>OUT</sub> absolute maximum rating must be observed.

Note 3:  $V_{OUT}$  < GND,  $V_{OUT}$  >  $V_{CC}$ 

Note 4: 180 mW in the range of  $T_a = -40$  to 85 °C. From  $T_a = 85$  to 125 °C a derating factor of -3.25 mW/°C shall be applied until 50 mW.

## 11. Operating Ranges (Note)

Characteristics	Symbol	Note	Rating	Unit
Supply voltage	V <sub>CC</sub>		4.5 to 5.5	V
Input voltage	V <sub>IN</sub>		0 to 5.5	V
Output voltage	V <sub>OUT</sub>	(Note1)	0 to 5.5	V
		(Note2)	0 to V <sub>CC</sub>	
Operating temperature	T <sub>opr</sub>		-40 to 125	Ĵ
Input rise and fall times	dt/dv		0 to 20	ns/V

Note: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs and bus inputs must be tied to either  $V_{CC}$  or GND.

Note1:  $V_{CC} = 0 V$ 

Note2: High or low state

#### 12. Electrical Characteristics

# 12.1. DC Characteristics (Unless otherwise specified, $T_a = 25$ °C)

Characteristics	Symbol	Test Condition		V <sub>CC</sub> (V)	Min	Тур.	Max	Unit
High-level input voltage	V <sub>IH</sub>	—		4.5 to 5.5	2.0	_	_	V
Low-level input voltage	VIL	—		4.5 to 5.5	_		0.8	V
High-level output voltage	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OH</sub> = -50 μA	4.5	4.40	4.50	_	V
			I <sub>OH</sub> = -8mA	4.5	3.94	_	_	
Low-level output voltage	V <sub>OL</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OL</sub> = 50 μA	4.5	_	0.0	0.1	V
			I <sub>OL</sub> = 8mA	4.5	_		0.36	
3-state output OFF-state leakage current	I <sub>OZ</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub> V <sub>OUT</sub> = V <sub>CC</sub> or GND	•	5.5	_	_	±0.25	μA
Input leakage current	I <sub>IN</sub>	V <sub>IN</sub> = 5.5 V or GND		0 to 5.5	_		±0.1	μA
Quiescent supply current	I <sub>CC</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND		5.5	_		4.0	μA
	I <sub>CCT</sub>	Per input: V <sub>IN</sub> = 3.4 V Other input: V <sub>CC</sub> or GND		5.5		—	1.35	mA
Output leakage current (Power-OFF)	I <sub>OPD</sub>	V <sub>OUT</sub> = 5.5 V		0		—	0.5	μΑ

# 12.2. DC Characteristics (Unless otherwise specified, Ta = -40 to 85 °C)

Characteristics	Symbol	Test Condition	n	V <sub>CC</sub> (V)	Min	Max	Unit
High-level input voltage	V <sub>IH</sub>	—		4.5 to 5.5	2.0	_	V
Low-level input voltage	V <sub>IL</sub>	—		4.5 to 5.5		0.8	V
High-level output voltage	V <sub>OH</sub>	$V_{IN} = V_{IH}$ or $V_{IL}$	I <sub>OH</sub> = -50 μA	4.5	4.40	—	V
			I <sub>OH</sub> = -8 mA	4.5	3.80	_	
Low-level output voltage	V <sub>OL</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OL</sub> = 50 μA	4.5	_	0.1	V
			I <sub>OL</sub> = 8 mA	4.5	_	0.44	
3-state output OFF-state leakage current	I <sub>OZ</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub> V <sub>OUT</sub> = V <sub>CC</sub> or GND	-	5.5	_	±2.50	μA
Input leakage current	I <sub>IN</sub>	V <sub>IN</sub> = 5.5 V or GND		0 to 5.5	_	±1.0	μA
Quiescent supply current	I <sub>CC</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND		5.5	_	40.0	μA
	I <sub>CCT</sub>	Per input: V <sub>IN</sub> = 3.4 V Other input: V <sub>CC</sub> or GND		5.5	_	1.50	mA
Output leakage current (Power-OFF)	I <sub>OPD</sub>	V <sub>OUT</sub> = 5.5 V		0	_	5.0	μΑ

# 12.3. DC Characteristics (Unless otherwise specified, $T_a = -40$ to 125 °C)

Characteristics	Symbol	Test Condition		V <sub>CC</sub> (V)	Min	Max	Unit
High-level input voltage	V <sub>IH</sub>	—		4.5 to 5.5	2.0	_	V
Low-level input voltage	V <sub>IL</sub>	—		4.5 to 5.5		0.8	V
High-level output voltage	V <sub>OH</sub>	$V_{IN} = V_{IH}$ or $V_{IL}$	I <sub>OH</sub> = -50 μA	4.5	4.40	_	V
			I <sub>OH</sub> = -8 mA	4.5	3.70	_	
Low-level output voltage	V <sub>OL</sub>	$V_{IN} = V_{IH}$ or $V_{IL}$	I <sub>OL</sub> = 50 μA	4.5	_	0.1	V
			I <sub>OL</sub> = 8 mA	4.5	_	0.55	
3-state output OFF-state leakage current	I <sub>OZ</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub> V <sub>OUT</sub> = V <sub>CC</sub> or GND		5.5	_	±10.0	μA
Input leakage current	I <sub>IN</sub>	V <sub>IN</sub> = 5.5 V or GND		0 to 5.5	_	±2.0	μA
Quiescent supply current	I <sub>CC</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND		5.5	_	80.0	μA
	I <sub>ССТ</sub>	Per input: V <sub>IN</sub> = 3.4 V Other input: V <sub>CC</sub> or GND		5.5	_	1.50	mA
Output leakage current (Power-OFF)	I <sub>OPD</sub>	V <sub>OUT</sub> = 5.5 V		0	_	20.0	μA

## 12.4. Timing Requirements (Unless otherwise specified, $T_a = 25^{\circ}C$ , Input: $t_f = t_f = 3 \text{ ns}$ )

Characteristics	Symbol	V <sub>CC</sub> (V)	Тур.	Limit	Unit
Minimum pulse width (LE)	t <sub>w(H)</sub>	$5.0\pm0.5$	_	6.5	ns
Minimum setup time	t <sub>S</sub>	$5.0\pm0.5$	_	1.5	ns
Minimum hold time	t <sub>h</sub>	$5.0\pm0.5$	_	3.5	ns

# 12.5. Timing Requirements

(Unless otherwise specified,  $T_a = -40$  to 85°C, Input:  $t_r = t_f = 3$  ns)

Characteristics	Symbol	V <sub>CC</sub> (V)	Limit	Unit
Minimum pulse width (LE)	t <sub>w(H)</sub>	$5.0\pm0.5$	8.5	ns
Minimum setup time	t <sub>S</sub>	$5.0\pm0.5$	1.5	ns
Minimum hold time	t <sub>h</sub>	$5.0\pm0.5$	3.5	ns

# 12.6. Timing Requirements (Unless otherwise specified, $T_a = -40$ to 125 °C, Input: $t_r = t_f = 3$ ns)

Characteristics	Symbol	V <sub>CC</sub> (V)	Limit	Unit
Minimum pulse width (LE)	t <sub>w(H)</sub>	$5.0\pm0.5$	8.5	ns
Minimum setup time	t <sub>S</sub>	$5.0\pm0.5$	2.0	ns
Minimum hold time	t <sub>h</sub>	$5.0\pm0.5$	3.5	ns

#### 12.7. AC Characteristics (Unless otherwise specified, $T_a = 25$ °C, Input: $t_r = t_f = 3$ ns)

Characteristics	Symbol	Note	Test Condition	V <sub>CC</sub> (V)	C <sub>L</sub> (pF)	Min	Тур.	Max	Unit
Propagation delay time	t <sub>PLH</sub> ,t <sub>PHL</sub>		—	$5.0\pm0.5$	15	_	7.7	12.3	ns
(LE-Q)					50		8.5	13.3	
Propagation delay time	t <sub>PLH</sub> ,t <sub>PHL</sub>		_	$5.0\pm0.5$	15	—	5.1	8.5	ns
(D-Q)					50	_	5.9	9.5	
3-state output enable time	t <sub>PZL</sub> ,t <sub>PZH</sub>		R <sub>L</sub> = 1 kΩ	$5.0\pm0.5$	15		6.3	10.9	ns
					50		7.1	11.9	
3-state output disable time	t <sub>PLZ</sub> ,t <sub>PHZ</sub>		R <sub>L</sub> = 1 kΩ	$5.0\pm0.5$	50	_	8.8	11.2	ns
Output skew	t <sub>osLH</sub> ,t <sub>osHL</sub>	(Note 1)	—	$5.0\pm0.5$	50	_	_	1.0	ns
Input capacitance	C <sub>IN</sub>		_				4	10	pF
Output capacitance	C <sub>OUT</sub>		—			_	9	_	
Power dissipation capacitance	C <sub>PD</sub>	(Note 2)	_				25	_	pF

Note 1: Parameter guaranteed by design. ( $t_{osLH} = |t_{PLH}m-t_{PLH}n|, t_{osHL} = |t_{PHL}m-t_{PHL}n|$ )

Note 2: C<sub>PD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load. Average operating current can be obtained by the equation.

 $I_{CC(opr)} = C_{PD} \times V_{CC} \times f_{IN} + I_{CC}/8$  (per latch)

And the total  $C_{PD}$  when n pcs of latch operate can be gained by the following equation.  $C_{PD}$  (total) = 14 + 11  $\times$  n

## 12.8. AC Characteristics

## (Unless otherwise specified, $T_a = -40$ to 85 °C, Input: $t_r = t_f = 3$ ns)

Characteristics	Symbol	Note	Test Condition	V <sub>CC</sub> (V)	C <sub>L</sub> (pF)	Min	Max	Unit
Propagation delay time	t <sub>PLH</sub> ,t <sub>PHL</sub>		—	$5.0\pm0.5$	15	1.0	13.5	ns
(LE-Q)					50	1.0	14.5	
Propagation delay time	t <sub>PLH</sub> ,t <sub>PHL</sub>		—	$5.0\pm0.5$	15	1.0	9.5	ns
(D-Q)					50	1.0	10.5	
3-state output enable time	t <sub>PZL</sub> ,t <sub>PZH</sub>		R <sub>L</sub> = 1 kΩ	$5.0\pm0.5$	15	1.0	12.5	ns
					50	1.0	13.5	
3-state output disable time	t <sub>PLZ</sub> ,t <sub>PHZ</sub>		R <sub>L</sub> = 1 kΩ	$5.0\pm0.5$	50	1.0	12.0	ns
Output skew	t <sub>osLH</sub> ,t <sub>osHL</sub>	(Note 1)	—	$5.0\pm0.5$	50	_	1.0	ns
Input capacitance	C <sub>IN</sub>		_				10	pF

Note 1: Parameter guaranteed by design. ( $t_{osLH} = |t_{PLH}m-t_{PLH}n|$ ,  $t_{osHL} = |t_{PHL}m-t_{PHL}n|$ )

# 12.9. AC Characteristics

#### (Unless otherwise specified, $T_a = -40$ to 125 °C, Input: $t_r = t_f = 3$ ns)

Characteristics	Symbol	Note	Test Condition	V <sub>CC</sub> (V)	$C_L (pF)$	Min	Max	Unit
Propagation delay time	t <sub>PLH</sub> ,t <sub>PHL</sub>		—	$5.0\pm0.5$	15	1.0	15.5	ns
(LE-Q)					50	1.0	17.0	
Propagation delay time	t <sub>PLH</sub> ,t <sub>PHL</sub>		—	$5.0\pm0.5$	15	1.0	11.0	ns
(D-Q)					50	1.0	12.0	
3-state output enable time	t <sub>PZL</sub> ,t <sub>PZH</sub>		R <sub>L</sub> = 1 kΩ	$5.0\pm0.5$	15	1.0	14.0	ns
					50	1.0	15.0	
3-state output disable time	t <sub>PLZ</sub> ,t <sub>PHZ</sub>		R <sub>L</sub> = 1 kΩ	$5.0\pm0.5$	50	1.0	14.0	ns
Output skew	t <sub>osLH</sub> ,t <sub>osHL</sub>	(Note 1)	_	$5.0\pm0.5$	50	_	1.0	ns
Input capacitance	C <sub>IN</sub>		—			_	10	pF

Note 1: Parameter guaranteed by design. ( $t_{osLH} = |t_{PLH}m-t_{PLH}n|$ ,  $t_{osHL} = |t_{PHL}m-t_{PHL}n|$ )

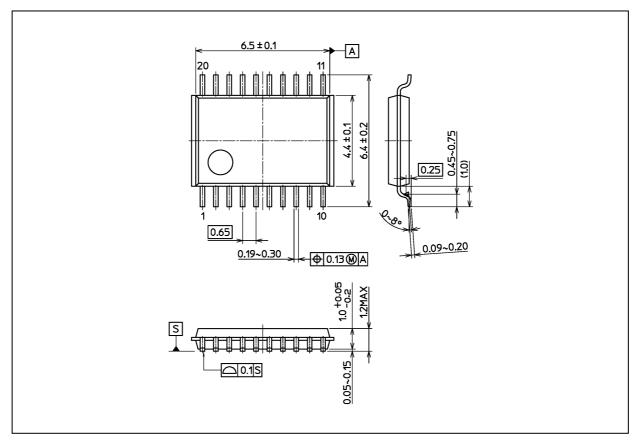
# 12.10. Noise Characteristics (Unless otherwise specified, $T_a = 25^{\circ}C$ , Input: $t_r = t_f = 3 \text{ ns}$ )

Characteristics	Symbol	Test Condition	V <sub>CC</sub> (V)	Тур.	Limit	Unit
Quiet output maximum dynamic V <sub>OL</sub>	V <sub>OLP</sub>	C <sub>L</sub> = 50 pF	5.0	1.1	1.5	V
Quiet output minimum dynamic V <sub>OL</sub>	V <sub>OLV</sub>	C <sub>L</sub> = 50 pF	5.0	-1.1	-1.5	
Minimum high-level dynamic input voltage	V <sub>IHD</sub>	C <sub>L</sub> = 50 pF	5.0	_	2.0	
Maximum low-level dynamic input voltage	V <sub>ILD</sub>	C <sub>L</sub> = 50 pF	5.0	_	0.8	



# **Package Dimensions**

Unit: mm



Weight: 0.071 g (typ.)

	Package Name(s)
Nickname: TSSOP20B	

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